

Notice of References Cited	Application/Control No. 10/797,105	Applicant(s)/Patent Under Reexamination HWANG ET AL.	
	Examiner Thomas D. Alunkal	Art Unit 2627	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0137909	07-2003	Ito et al.	369/47.14
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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